

TEXT LISTING

068-000433-03

PROGRAM

ECLIPSE SC-MEMORY TEST

TEXT TAPE

097-000433-03

ABSTRACT

THE SC-MEMORY TEST CONSISTS OF A SERIES OF SC-MEMORY TESTS AND A SIMPLE SUPERVISOR PROGRAM, THE DIAGNOSTIC LINKER. THE DIAGNOSTIC LINKER IS A PROGRAM DESIGNED TO "LINK" THE VARIETY OF SC MEMORY TESTS

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0001 .MAIN          MACH0 REV 06.30          08156:PS 12/04/78
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07 *****
08 : NAME: ECLSCMT.TX          PART NUMBER: 097-000433
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12 : DESCRIPTION: ECLIPSE SC-MEMORY IFSY
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15 : REVISION HISTORY:
16 :
17 :   REV.          DATE
18 :
19 :   00          12/31/76
20 :   01          06/17/77
21 :   02          09/01/78
22 :   03          11/10/78
23
24
25 : COPYRIGHT (C) DATA GENERAL CORPORATION, 1976, 1977, 1978
26 : ALL RIGHTS RESERVED.
27 *****

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: ECLIPSE SC-MEMORY TEST
: ABSTRACT
: 1. THE SC-MEMORY TEST CONSISTS OF A SERIES
: OF SC-MEMORY TESTS AND A SIMPLE
: SUPERVISOR PROGRAM. (THE DIAGNOSTIC LINKER)
:
: THE DIAGNOSTIC LINKER IS A PROGRAM
: DESIGNED TO "LINK" THE VARIETY OF
: SC MEMORY TESTS.
:
: MACHINE REQUIREMENTS
: 2. ECLIPSE PROCESSOR
: 2.2 4K TO 512K OF READ/WRITE MEMORY
: (ALLOWS FOR EXPANSION IN 1K INCREMENTS
: BUT MEMORY MUST BE CONTIGUOUS)
: 2.3 MAP OPTION (OPTIONAL)
: 2.4 REAL TIME CLOCK (OPTIONAL)
: 2.5 ERROR CORRECTION OPTION
:
: 2.6 PREREQUISITES
: 2.6.2 SOFTWARE
: THE ECLIPSE CPU DIAGNOSTICS , AND MAP DIAGNOSTICS
: SHOULD HAVE
: BEEN RUN BEFORE ATTEMPTING THIS TEST.
:
: 3. SWITCH SETTINGS
: 3.1 AUTO-SIZE AND GO START AT 200
: 3.2 MANUAL SELECT/DELETE TESTS START AT 206
: 3.3 IGNORE MAP START AT 210

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10005 .MAIN
01 ERROR DESCRIPTION
02 :
03 : MOST ERRORS DETECTED BY EITHER
04 : THE INDIVIDUAL TESTS OR
05 : BY THE DIAGNOSTIC LINKER WILL
06 : RESULT IN AN ERROR TYPEOUT. SOME
07 : SMALL NUMBER OF HIGHLY IMPROBABLE
08 : ERRORS MAY RESULT IN A PROGRAM HALT
09 : IF THEY ARE OF A NATURE THAT THE LINKER
10 : CAN'T RECOVER FROM AND LOGICALLY PROCEED,
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5.1 ERROR CORRECTION ERRORS
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: IF THE ERROR CORR. OPTION EXISTS AND HAS BEEN
: SELECTED, MEMORY ERRORS WILL CAUSE ERROR
: CORRECTION INTERRUPTS.

5.1.1 UPON DETECTION OF AN ERCC ERROR THE FOLLOWING
: WILL BE OUTPUTTED:
:
: ERCC ERROR INTERRUPT
: ERCC-CODE # ERRORS
:   XXX   XYZ
: TEST#  DIR  DIA  INTR ADDR
:   000   JJJ  YYY  ZZZZ
:
: WHERE,
:   XXX= ERCC CODE
:   XYZ= #ERRORS SINCE LAST REPORT
:   000= TEST# EXECUTING
:   JJJ= DIR FROM ERCC
:   YYY= DIA FROM ERCC
:   ZZZZ=ADDR OF INTERRUPT
:
: NOTE: IF FLIPSE TYPE IS E130 OR M600
:   DIR: BITS 0-4=CODE(SEE 5.1.2)
:   DIA: BITS 13-15=COMPLEMENT OF EXTENDED PHYS ADDR
:   01A: BITS 0-3=COMPLEMENT OF LO-ORDER PHYS ADDR
:   01B: BITS 12-15=COMPLEMENT OF LO-ORDER PHYS ADDR
:   01C: BITS 4-11=0

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5.1.2 ERCC CODES
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: FOR YOUR CONVENIENCE THE FOLLOWING TABLE
: IS INCLUDED TO HELP DETERMINE WHICH BIT
: IS FAILING IN AN ERROR CORRECTION MEMORY.
: COR.CODE
: 0 NO ERROR
: 1 CHECK BIT 4
: 2 CHECK BIT 3
: 3 DATA BIT 0
: 4 CHECK BIT 2
: 5 DATA BIT 1
: 6 MULTIPLE BIT
: 7 DATA BIT 3
: 10 CHECK BIT 1
: 11 DATA BIT 4
: 12 ALL 21 BITS WERE=1
: 13 DATA BIT 6
: 14 DATA BIT 7
: 15 DATA BIT 8
: 16 DATA BIT 9
: 17 MULT. BITS FAILED
: 20 CHECK BIT 0
: 21 DATA BIT 11
: 22 DATA BIT 12
: 23 DATA BIT 13
: 24 DATA BIT 14
: 25 ALL 21 BITS READ AS 0'S
: 26 DATA BIT 2
: 27 MULTIPLE BITS
: 30 DATA BIT 10
: 31 MULTIPLE BITS
: 32 DATA BIT 5
: 33 MULTIPLE BITS
: 34 DATA BIT 15
: 35 MULTIPLE BITS
: 36 SAME
: 37 SAME
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10007  -MAIN
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EXAMPLES:
:MAPPED ERROR TYPEOUT
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:MASFST (COMPLEMENT TEST)
:C(X) C(Y) LOC(X) LOC(Y) C(X) C(Y) LOC(X) LOC(Y)
:000000 000010 040010 047767 000000 000100 016010 017345
:SCRLO/HI 010000 077777 SCRLO/HI 016000 017777
:TSTLO/HI 21 49 TSTLO/HI 7 7 TYPE ANY KEY
:PHSLO/HI 4 7A PHSLO/HI 3 51

:NOTF THAT THE SCRATCH LIMITS IN THE MAPPED EXAMPLE ARE
:LOGICAL ADDRESSES AND NOT PHYSICAL. ALSO THAT TSTLO/HI
:IS DIFFERENT FROM PHSLO/HI.

: TO DETERMINE PHYSICAL ADDRESS OF A LOCATION
: WHICH IS MAPPED SUBTRACT SCRLO FROM THE
: LOGICAL ADDRESS,ADD THE DIFFERENCE TO TSTLO
: EXPRESSED AS AN OCTAL ADDRESS.

: IF SW6=1 THE
: TEST WILL HALT WAITING FOR
: THE OPERATOR TO PRESS A KEY
: ON THE CONSOLE

10008  -MAIN
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PROGRAM INITIALIZE
: 6.0
: THE DIAGNOSTIC LINKER INITIALIZES ITSELF
: AND INDIVIDUAL TESTS IN THE FOLLOWING
: SEQUENCE:
: 1. SYSTEM IS RESET.
: 2. ANY OTHER NECESSARY
: CONSTANTS ARE INITIALIZED
: 3. MEMORY IS SIZED IN 1K INCREMENTS
: 4. LINKER THEN TYPES THE PROGRAM
: NAME AND REVISION LEVEL,SYSTEM SIZE,
: MAP OPTION INFORMATION ALONG WITH
: THE PROGRAM RUN LIST (AND WILL ALLOW THE
: OPERATOR TO SELECT OR DELETE SPECIFIC TESTS
: IF START WAS 206
: OR 210).
: 5.1 OPTION SELECTION
: IF THE PROGRAM WAS NOT AUTOSTARTED
: (NOT LOC 200) THE LINKER WILL PRINT
: "OPTIONS?" AND WAIT FOR A CARRIAGE RETURN
: TO START EXECUTING THE TESTS.
: THIS ALLOWS THE OPERATOR TO SET UP
: THE KEY ENTRY OPTIONS INCLUDING
: KEY "T" WHICH ALLOWS SETTING OF MEMORY
: TEST AREA LIMITS.

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10009 .MAIN
01 PROGRAM EXECUTION
02 ONCE THE LINKER HAS COMPLETED ALL
03 INITIALIZATION THE FOLLOWING SERIES
04 OF OPERATIONS IS LOUPED THROUGH
05
06
07 1. LINKER SEARCHES THRU LIST OF TESTS
08 UNTIL IT FINDS ONE WHICH IS
09 NOT DELETED.
10
11 2. LINKER THEN SETS UP SEGMENT SIZE
12 RAISED ON THE VALUE IN THE
13 PARAMETER TABLE FOR EACH TEST.
14
15 3. A. IF MAP IS USED THE LINKER MAPS
16 PAGE 0 AND THE TEST TO ITSELF
17 AND THE TEST SEGMENT AREA TO
18 LOGICAL AREA STARTING AT 10000
19 UP TO 77777.
20
21 B. IF MAP ISN'T USED THEN THE LINKER
22 PASSES THE ACTUAL PHYSICAL ADDRESS
23 TO THE TEST.
24
25 4. THE LINKER RE-ENTERS THE TEST WITH
26 EACH SEGMENT UNTIL THE AREA SELECTED
27 HAS BEEN EXERCISED. AFTER COMPLETION
28 THE LINKER SEARCHES FOR ANOTHER TEST
29 IN THE SERIES.
30
31 5. AFTER SEVERAL PASSES OF EACH TEST
32 SELECTED THE LINKER WILL PRINT
33 "PASS XX" IF SWREG BIT 4 HAS NOT
34 BEEN SET.
35
36 6. IF PROGRAM WAS LOADED FROM DTOS WITH
37 EITHER CAT OR KITTEN IT WILL START
38 CAT/KITTEN AFTER FIRST "PASS".
39
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10010 .MAIN
01 7.0 TEST DESCRIPTIONS
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05 7.1 ERROR CORRECTION TEST
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07 THIS TEST PRINTS THE ERROR CORRECTION MESSAGES
08 WHICH WERE CAUSED BY OTHER TEST MEMORY FAILURES.
09 IF NOT SELECTED THEN NO ERROR CORRECTION WILL OCCUR.
10
11 7.2 DATA EQUALS ADDRESS TEST
12
13 THIS TEST WRITES THE ADDRESS OF EACH
14 LOCATION INTO EACH LOCATION AS DATA
15
16 IT THEN READS BACK ALL LOCATIONS AND CHECKS
17 THE VALUE READ AGAINST THE ADDRESS.
18
19 7.3 ISZ INSTRUCTION TEST
20
21 7.3.1 FORWARD ISZ TEST
22
23 THIS TEST FILLS ALL SCRATCH WITH A MINUS
24 ONE PATTERN, THEN PERFORMS A ISZ INSTR.
25 FOLLOWED BY A READ OF THE LOC. TO
26 VERIFY IT CONTAINS A ZERO. THIS IS
27 DONE AT EACH LOCATION FROM SCRLO TO
28 SCRHI.
29
30 7.3.2 REVERSE ISZ TEST
31
32 THIS TEST IS IDENTICAL TO THE ABOVE TEST
33 EXCEPT THAT THE MEMORY ADDRESSES ARE SCANED
34 FROM SCRHI TO SCRLO.
35
36 7.4 MARCH
37
38 THIS TEST FUNCTIONALLY CHECKS EACH BIT IN THE
39 MEMORY AND THE ADDRESSING .
40
41 THIS TEST USES EITHER RANDOM DATA (KEY OPTION "q"=0)
OR ALL ONES DATA (OPTION "q"= 1).
42
43 A TEST PATTERN IS WRITTEN INTO THE BACKGROUND
44 STARTING AT SCRLO AND ENDING AT SCRHI.
45 ADDRESSING IS THEN SCANNED ACROSS THIS RANGE
46 AND AT EACH ADDRESS THE TEST WORD IS
47 READ AND A COMPLEMENTED TEST WORD IS
48 WRITTEN BACK INTO THE SAME LOCATION.
49
50 THE DATA IS THEN COMPLEMENTED AND THE ABOVE
51 SEQUENCE REPEATED.
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53 THE PROCESS IS THEN REPEATED
54 STARTING AT SCRHI AND PROCEEDING TO SCRLO .
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7.5 MASEST (SEGMENT MAX = 2)
CHECKS FOR DESTRUCTION OF STOPPED DATA THAT MAY
RESULT FROM MULTIPLE SELECTION OF ADDRESSES
INTERNAL TO THE MEMORY CAUSED BY FAULTY
DECODERS OR LOGICAL SWITCHING HAZARDS.
ALTERNATE ALL ONE'S, ALL ZERO'S ARE WRITTEN IN
ASCENDING LOCATIONS. EACH LOCATION IS THEN READ
AND VERIFIED WHILE GOING THRU THE ADDRESS
SEQUENCE OF ADDRESS, COMPLEMENT OF ADDRESS,
ADDRESS PLUS ONE, COMPLEMENT OF ADDRESS PLUS
ONE, ETC. - MEMORY IS THEN READ SEQUENTIALLY
AND THE ALTERNATE ONE'S ZERO'S PATTERN
VERIFIED.
7.6 SLOIAG (SEGMENT MAX = 1)
THIS TEST IS NOT SELECTED IF
THE PROGRAM IS STARTED AT LOC 200.
THIS TEST FILLS THE BACKGROUND WITH ALL 0'S
PATTERN AND THEN WRITES A DIAGONAL PATTERN
USING THE COMPLEMENT OF THE BACKGROUND.
THE ARRAY IS THEN VERIFIED READING DOWN EACH
COLUMN INSTEAD OF ACROSS EACH ROW.
IF NO ERRORS ARE FOUND THE PROCES IS REPEATED
WITH THE DIAGONAL SHIFTED ONE POSITION UNTIL
ALL POSITIONS ARE USED.
NEXT THE BACKGROUND IS COMPLEMENTED AND THE
TEST REPEATED.
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7.7 GALPAT (SEGMENT MAX = 1)
THIS TEST DOESN'T RUN ON AN AUTOSTART.
THIS TEST CHECKS ADDRESSING, INTERACTION
BETWEEN BITS, AND PATTERN AND SEQUENCE
DEPENDENCY FOR TRANSIENT PERFORMANCE.
THIS TEST EITHER USES RANDOM DATA OR ALL ONES
(SEE KEY OPTION "0")
A BACKGROUND PATTERN IS WRITTEN THRU-OUT
MEMORY. THEN STARTING AT THE FIRST LOCATION,
A TEST WORD IS WRITTEN(COMPLEMENT OF
BACKGROUND).
MEMORY IS THEN READ IN ALL LOCATIONS IN THE
FOLLOWING SEQUENCE: BACKGROUND, TEST WORD
NEXT BACKGROUND, TEST WORD, NEXT
BACKGROUND, ETC.
AFTER COMPLETION OF A PASS FROM SCRL0 TO
SCRH1, THE TEST WORD IS MOVED TO THE
NEXT SEQUENTIAL LOCATION AND THE
PROCESS OF READING REPEATED.
THIS CONTINUES UNTIL THE TEST WORD HAS
BEEN LOCATED IN EVERY MEMORY LOCATION
FROM SCRL0 TO SCRHI.
AT COMPLETION, THE ABOVE SEQUENCE IS
REPEATED USING A COMPLEMENTED PATTERN.
FOR SAKE OF TYPEOUTS:
LOC(X) = TEST WORD LOCATION
LOC(Y) = BACKGROUND LOCATION
7.8 GALWREC (SEGMENT MAX = 1)
THIS TEST DOESN'T RUN ON AN AUTOSTART.
THIS TEST CHECKS ALL POSSIBLE WRITES
FOLLOWED BY READS AT DIFFERENT LOCATIONS
THIS TEST EITHER USES RANDOM DATA OR ALL ONES
(SEE KEY OPTION "0")
A BACKGROUND PATTERN(B) IS WRITTEN THRU-
OUT MEMORY. EVERY PAIR OF ADDRESSES ARE
THEN CHECKED IN THE FOLLOWING MANNER,
STARTING WITH THE FIRST LOCATION,LOC(X):
WRITE T((INVERTED B) IN LOC(Y)=(X+1),READ
B IN LOC(X),WRITE 0 IN LOC(Y),
READ R IN LOC(X),WRITE T IN LOC(Y)=(Y+1)
READ R IN LOC(X),ETC.
AFTER ALL LOC. HAVE BEEN CHECKED IN
RELATION TO LOCATION ONE(X), THE SEQUENCE IS
REPEATED WITH RESPECT TO LOC(X)=(X+1), ETC.
AT COMPLETION, THE ABOVE SEQUENCE IS
REPEATED USING A COMPLEMENTED PATTERN.

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0013 .MAIN

**#00000 TOTAL ERRORS, 00000 PASS 1 ERRORS